

Notice of References Cited	Application/Control No. 10/553,095		Applicant(s)/Patent Under Reexamination AOKI ET AL.	
	Examiner Wayne K. Leung		Art Unit 4171	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0028828 A1	02-2004	Aoki et al.	427/387
	B	US-			
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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